

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09/809,440	HOUGHAM, GARETH
	Examiner	Art Unit
	Monica A Fontaine	1732

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	B	US-5,512,131	04-1996	Kumar et al.	216/13
	C	US-5,731,253	03-1998	Sangokoya, Samuel A.	502/102
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	E	US-4,528,354	07-1985	McDougal, John R.	264/209.6
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NON-PATENT DOCUMENTS

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	U	"Siloxane Polymers for High-Resolution, High-Accuracy Soft Lithography." B. Michel et al. Macromolecules 33 (8), 3042-3049, 2000.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.